

FIG. 1

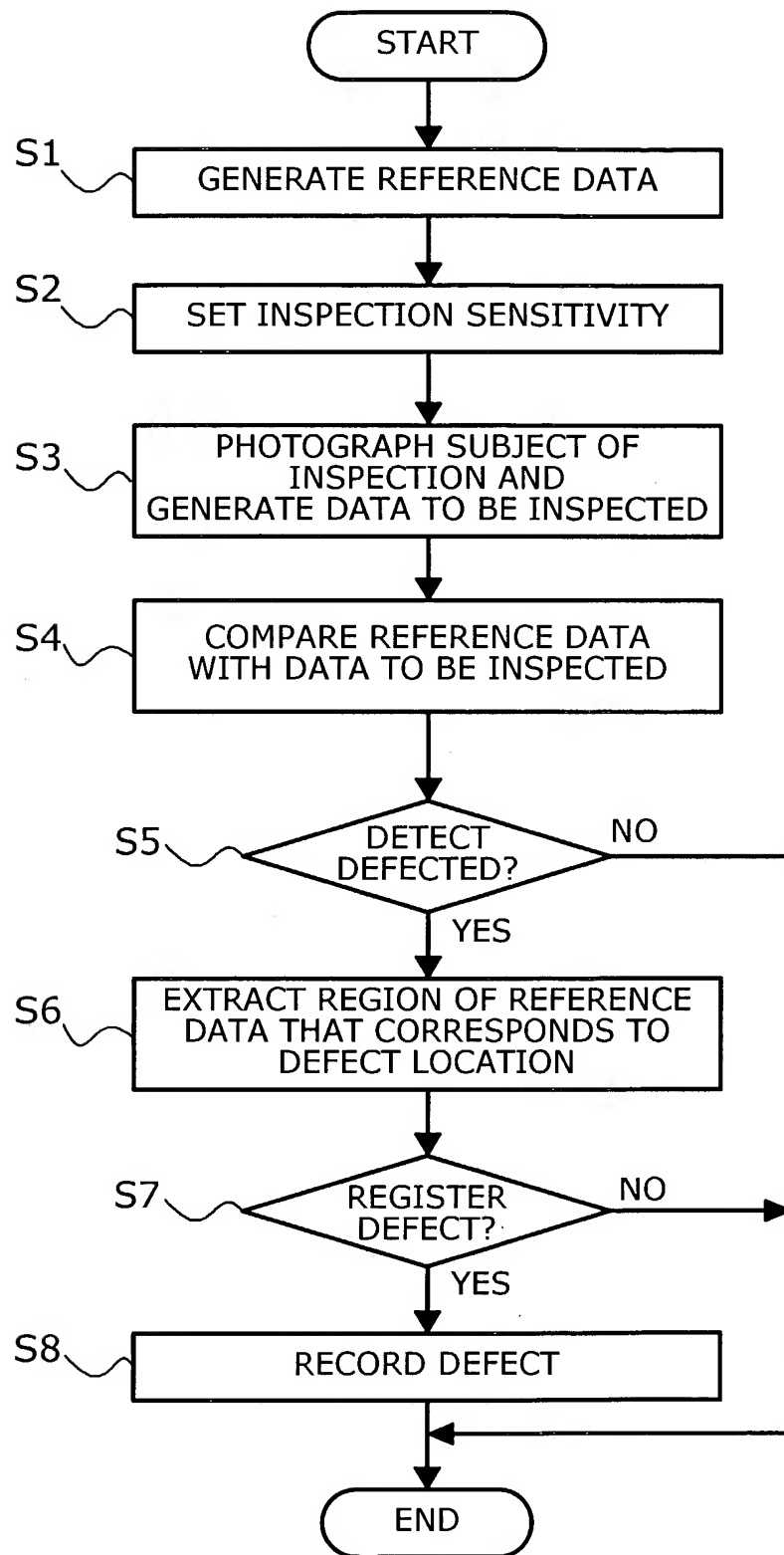


FIG. 2

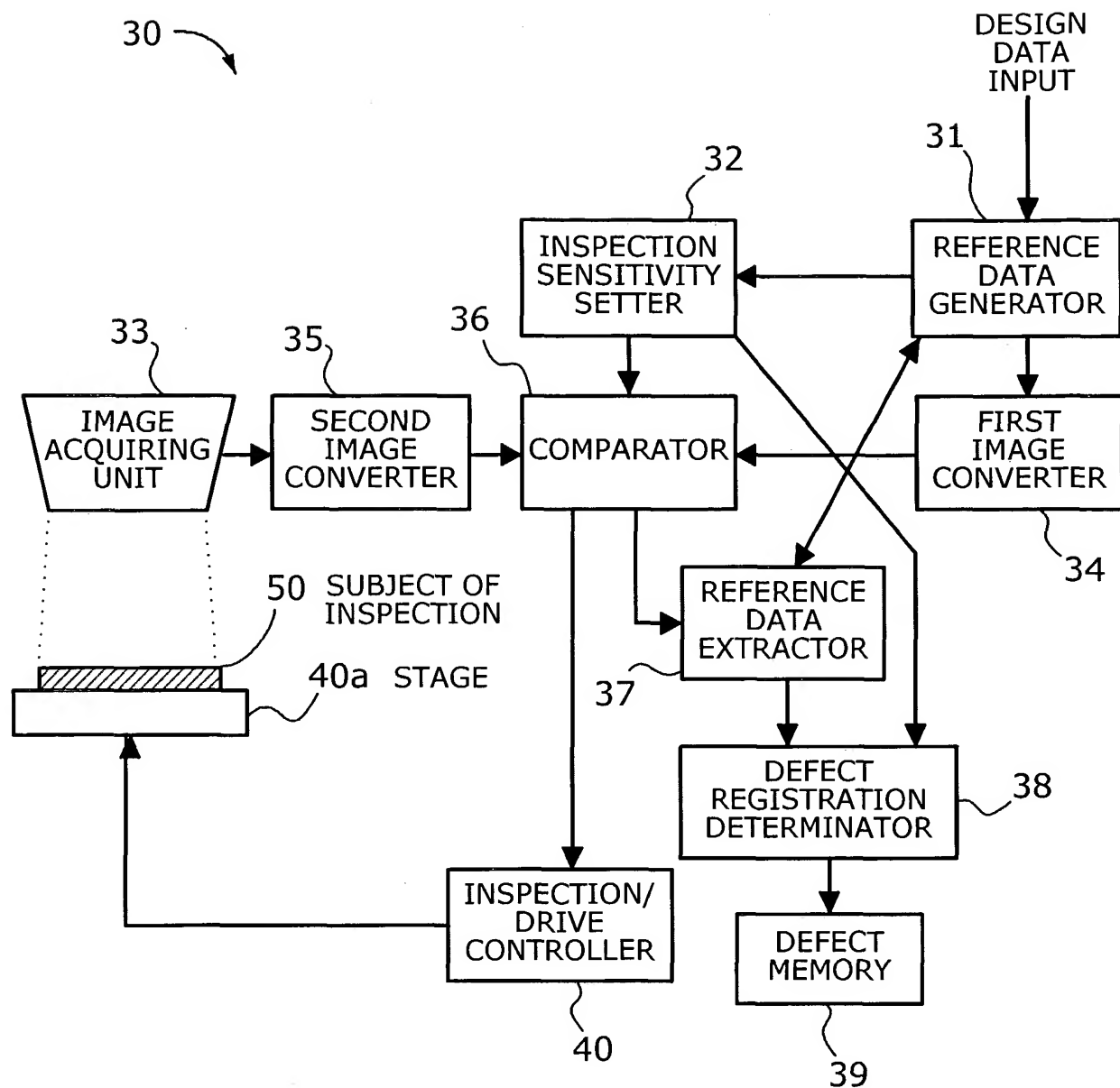


FIG. 3

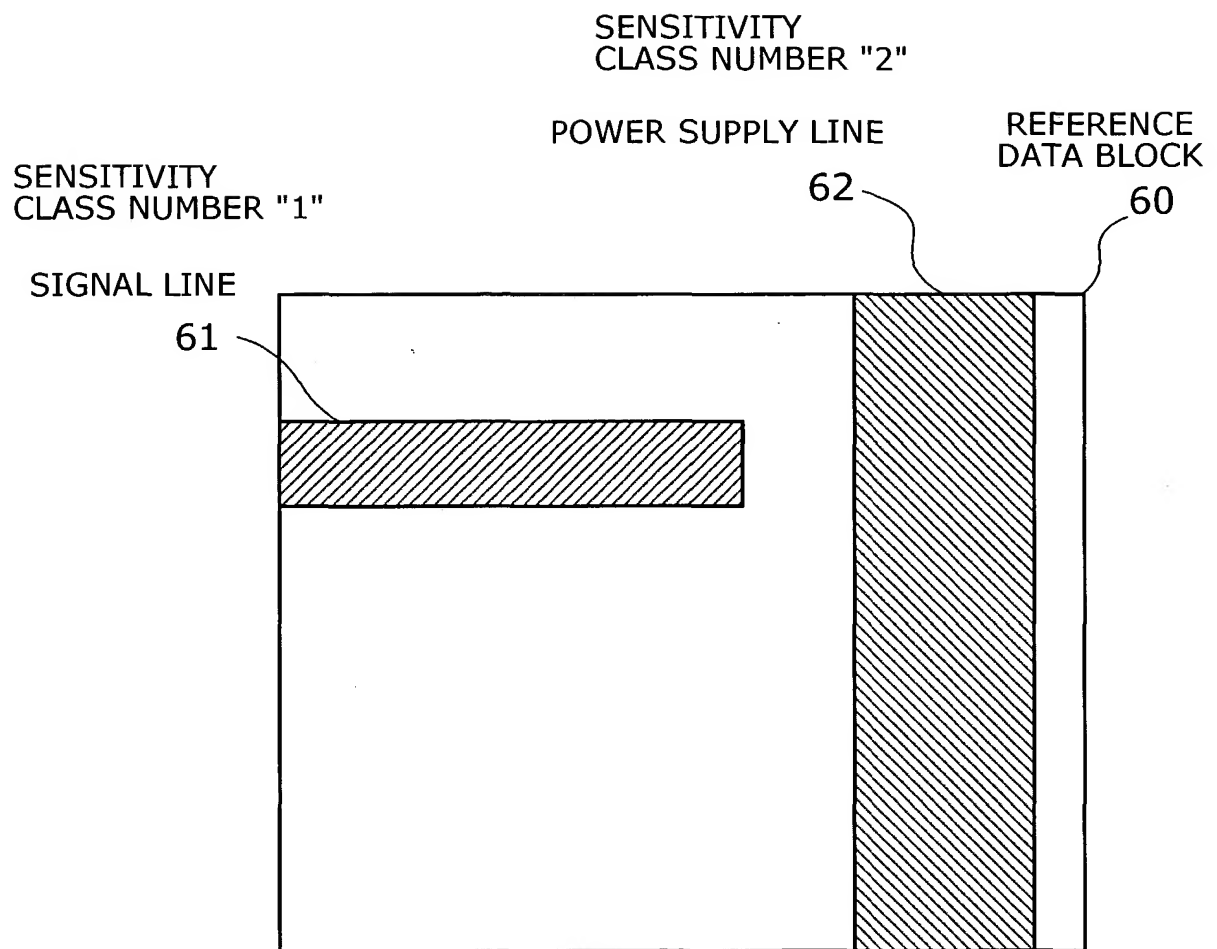


FIG. 4

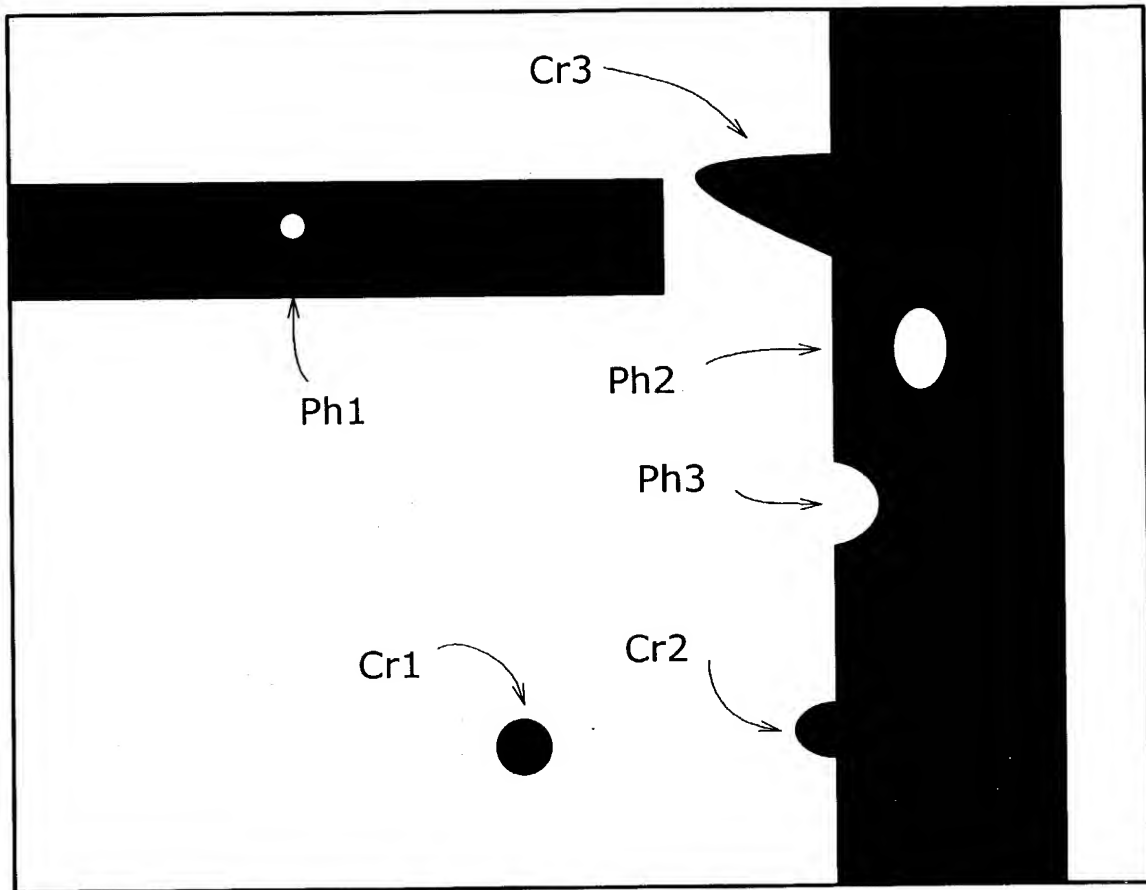


FIG. 5

DEFECT PATTERN AREA

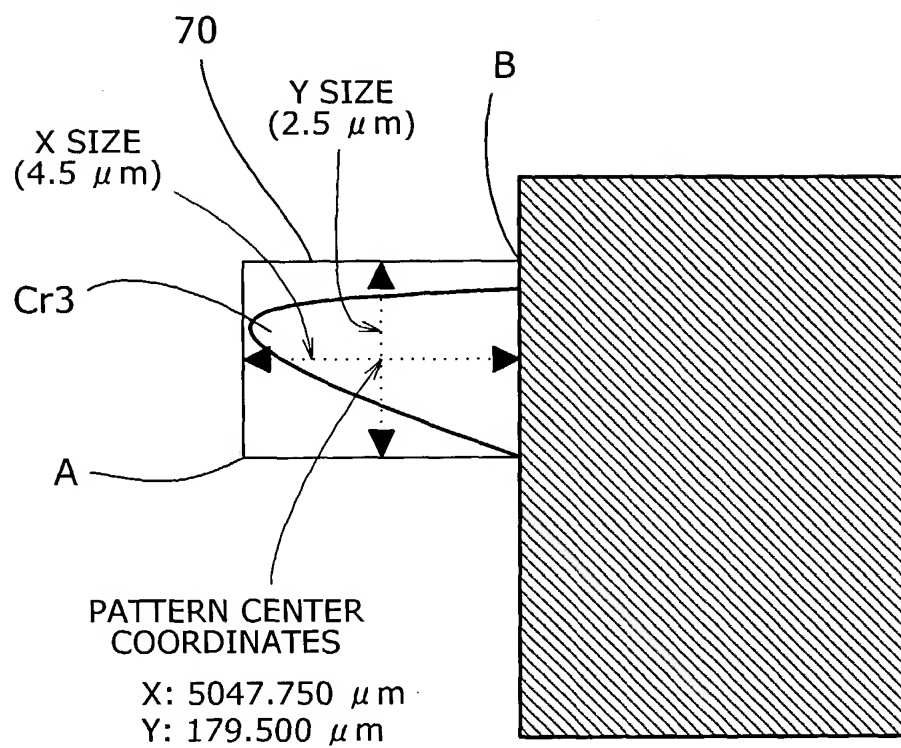


FIG. 6

MULTIPLE-BLOCK STRUCTURE OF REFERENCE DATA

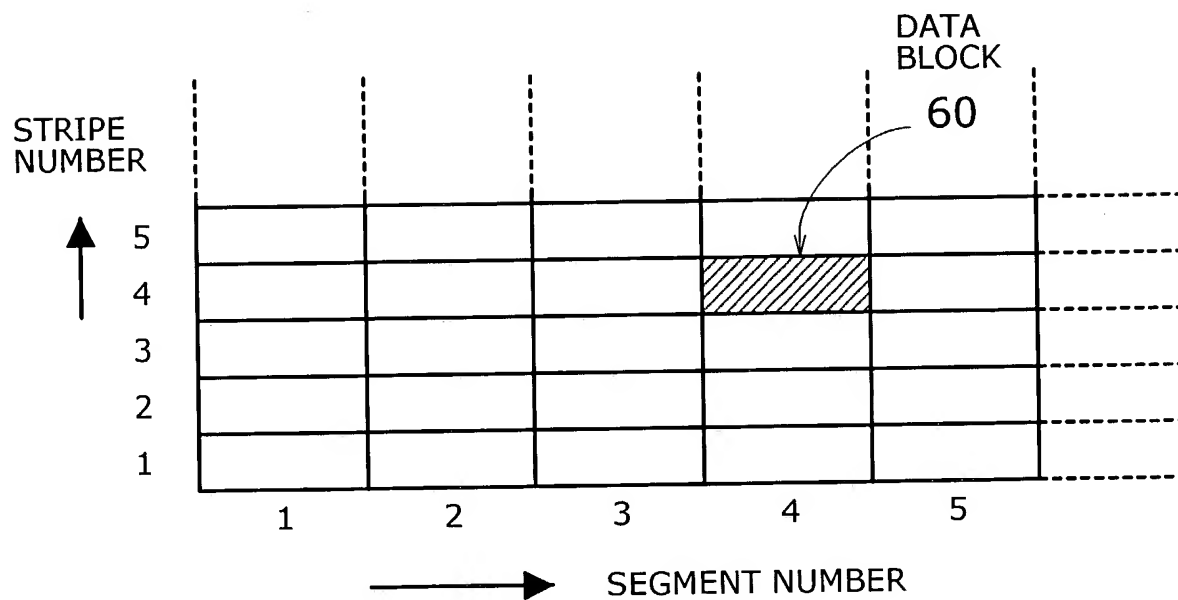


FIG. 7

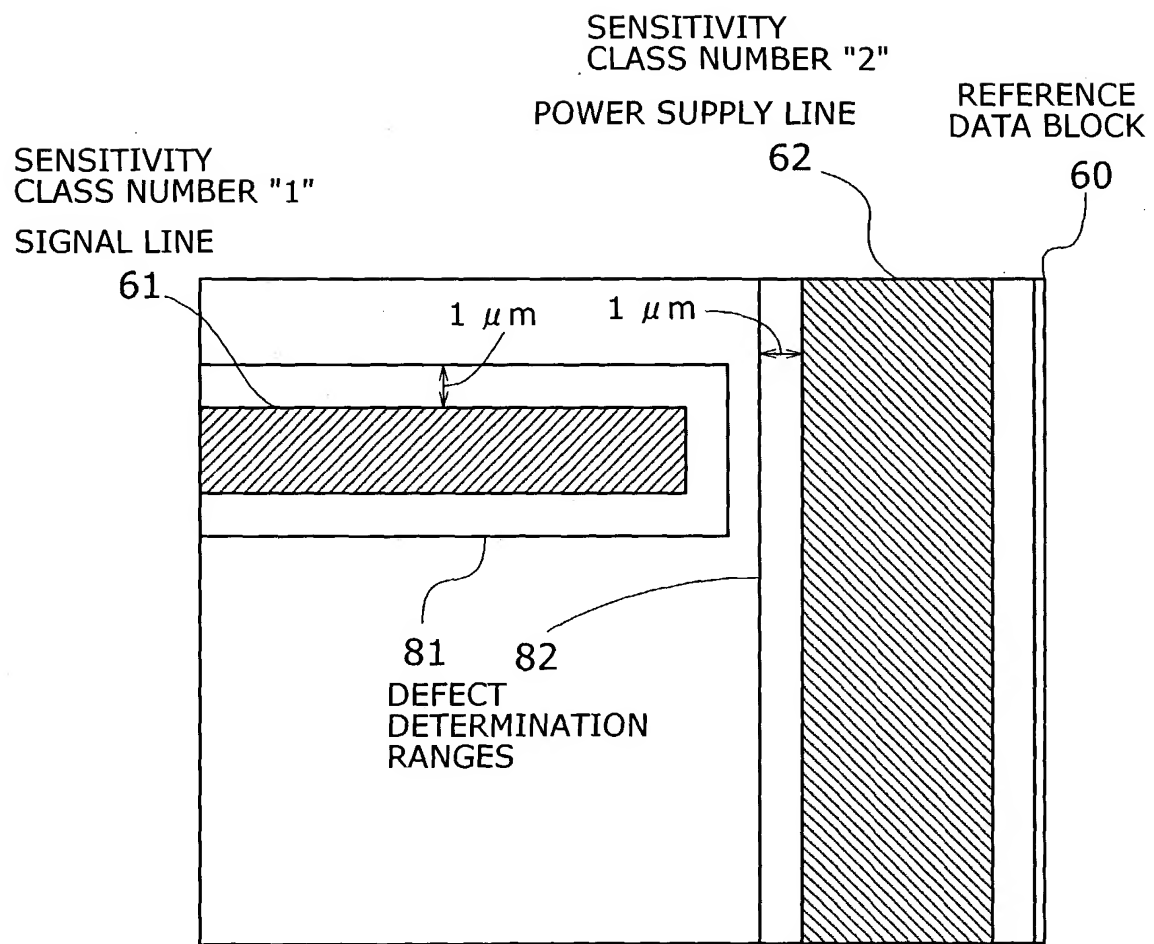


FIG. 8

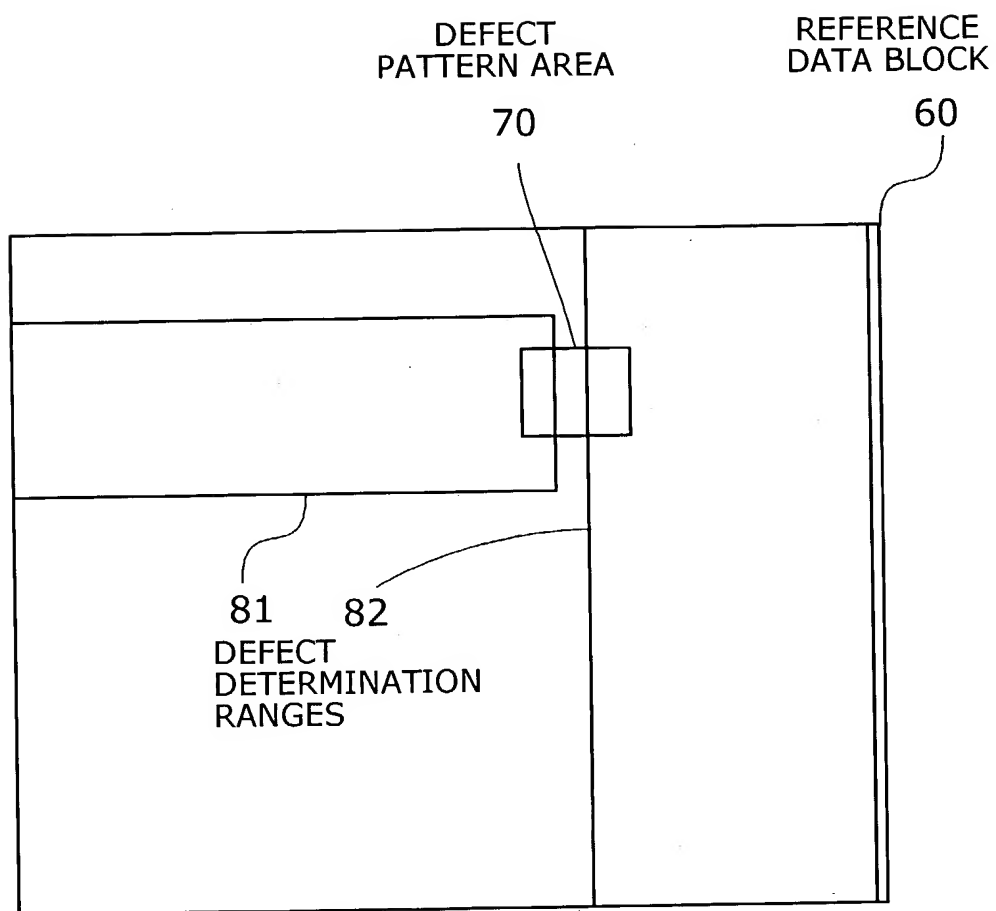


FIG. 9



FIG. 10

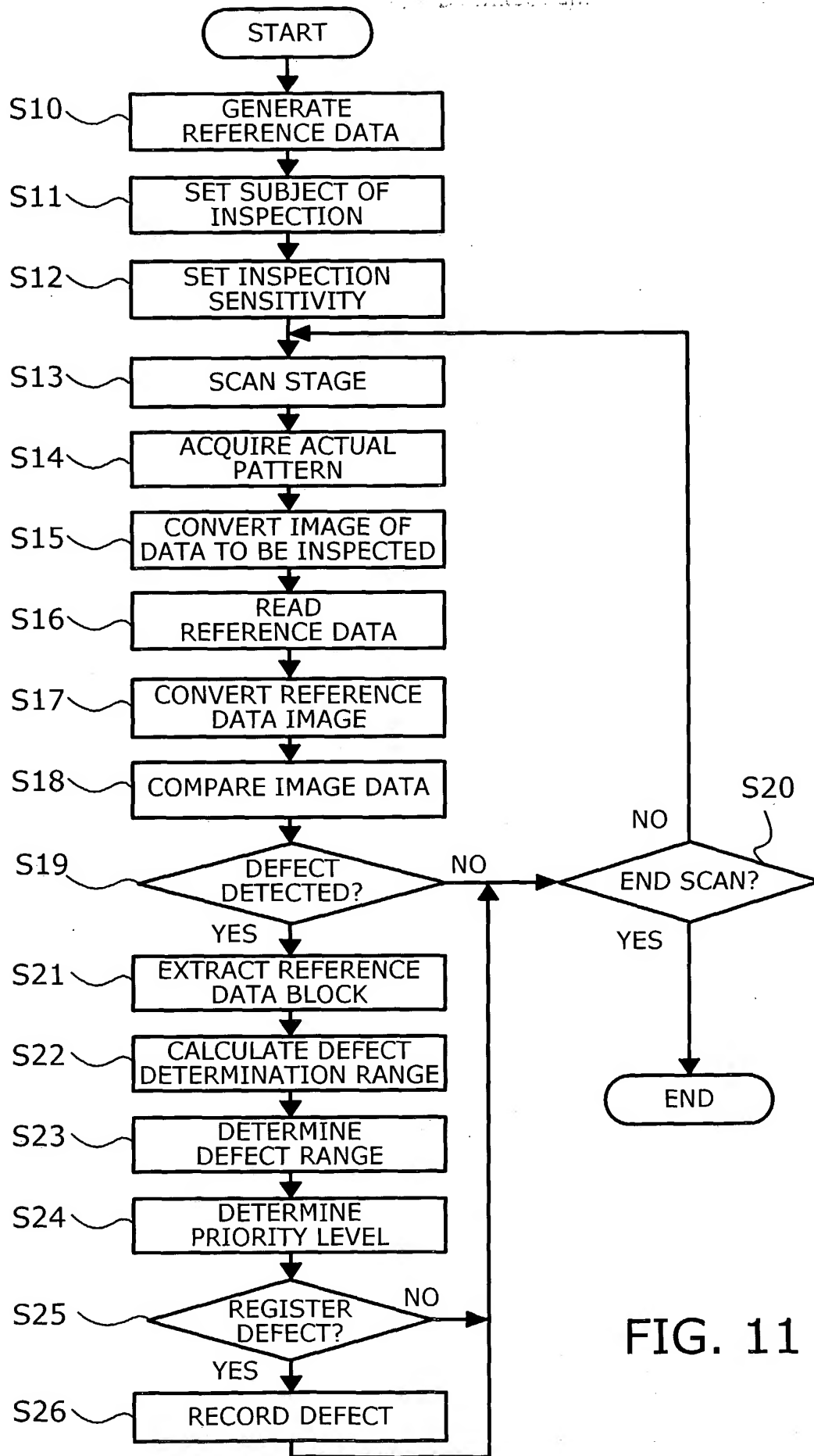


FIG. 11

INSPECTION DEVICE

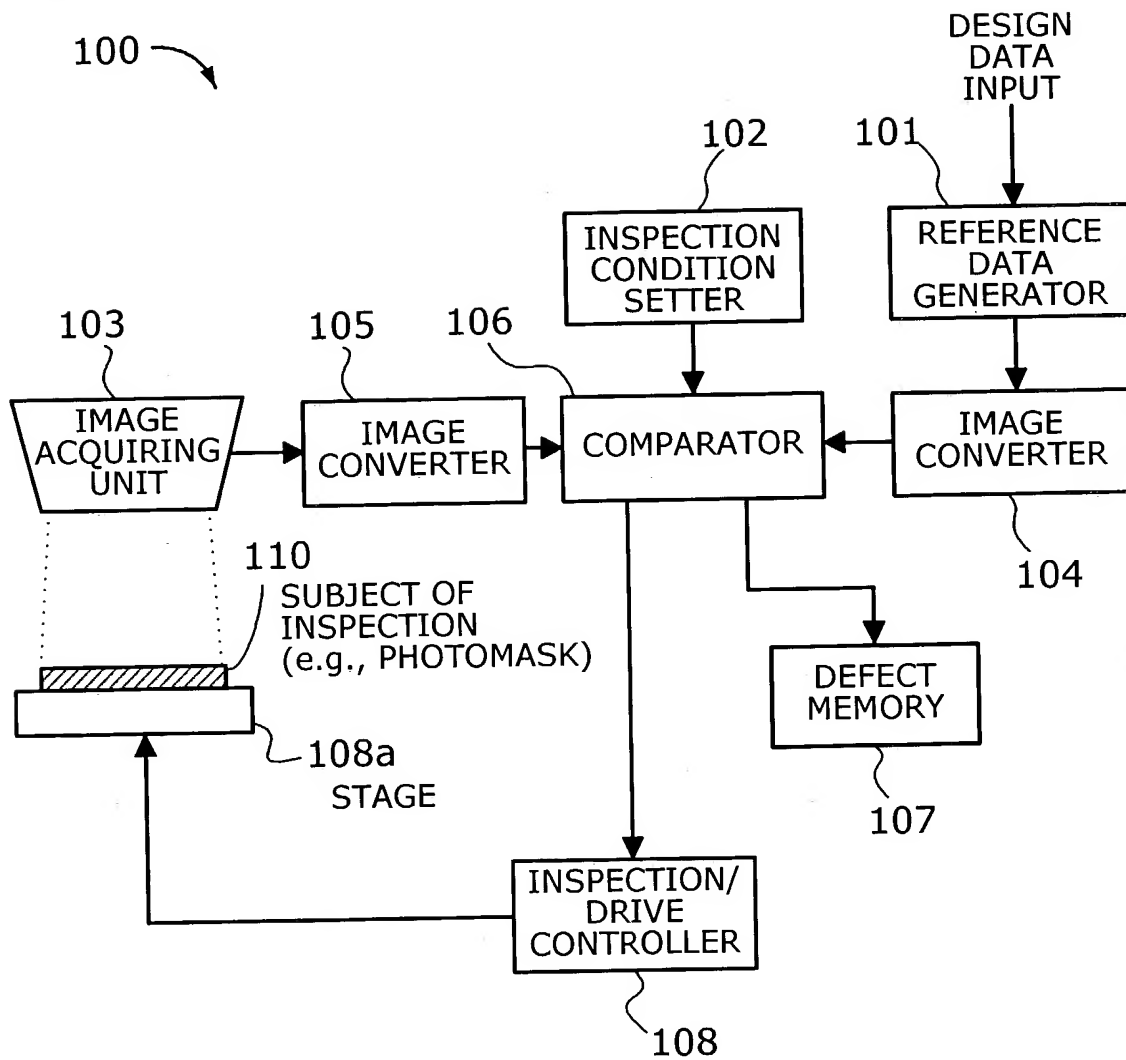


FIG. 12
PRIOR ART